



Product Change Notification / ASER-25RLDG830

Date:

29-Mar-2021

Product Category:

Memory

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4279.002 Final Notice: Qualification of GTK as a new assembly site for selected SST39VF3201xx and SST39VF3202xx device families available in 48L TSOP (12x20mm) package.

Affected CPNs:

[ASER-25RLDG830_Affected_CPN_03292021.pdf](#)
[ASER-25RLDG830_Affected_CPN_03292021.csv](#)

Notification Text:

PCN Status:Final notification.

PCN Type:

Manufacturing Change

Microchip Parts Affected:

Please open one of the files found in the Affected CPNs section.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of GTK as a new assembly site for selected SST39VF3201xx and SST39VF3202xx device families available in 48L TSOP (12x20mm) package.

Pre Change:Assembled at LPI using 8340 die attach material, G700 mold compound and 183x161 mils lead frame paddle size.

Post Change:Assembled at GTK using EN-4900GC die attach material, G600F mold compound and 280x210 mils lead frame paddle size.

Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	Lingsen Precision Industries, LTD. (LPI)	GREATEK ELETRONIC INC. (GTK)
Wire material	Au	Au
Die attach material	8340	EN-4900GC
Molding compound material	G700	G600F
Lead frame material	C7025	C7025
Lead frame paddle size	183x161	280x210

Impacts to Data Sheet:None

Change Impact:

None.

Reason for Change:

To improve on-time delivery performance by qualifying GTK as a new assembly site.

Change Implementation Status:In Progress

Estimated First Ship Date:April 30, 2021 (date code: 2118)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	February 2021				March 2021					April 2021			
Workweek	6	7	8	9	10	11	12	13	14	15	16	17	18
Initial PCN Issue Date		X											
Qual Report Availability									X				
Final PCN Issue Date									X				
Estimated Implementation Date													X

Method to Identify Change:Traceability code

Qualification Report

Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:February 12, 2020: Issued initial notification.

March 29, 2021: Issued final notification. Attached the Qualification Report. Provided estimated first ship date to be on April 30, 2021.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products

Attachments:

[PCN_ASER-25RLDG830_Qual Report.pdf](#)

[PCN_ASER-25RLDG830_Pre and Post Change Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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Affected Catalog Part Numbers (CPN)

SST39VF3201B-70-4C-EKE

SST39VF3202B-70-4C-EKE

SST39VF3201B-70-4I-EKE

SST39VF3202B-70-4I-EKE

SST39VF3201B-70-4I-EKE-MCL

SST39VF3202B-70-4I-EKE-MCM

SST39VF3201B-70-4I-EKE-T



**QUALIFICATION REPORT SUMMARY
RELIABILITY LABORATORY**

PCN#: ASER-25RLDG830

**Date
March 02, 2021**

Qualification of GTK as a new assembly site for selected products available in 48L TSOP package. The qualification of SST39VF3201xx and SST39VF3202xx device families available in 48L TSOP (12x20mm) package will be qualify by similarity (QBS).



MICROCHIP PACKAGE QUALIFICATION REPORT

Purpose	Qualification of GTK as a new assembly site for selected products available in 48L TSOP package. The qualification of SST39VF3201xx and SST39VF3202xx device families available in 48L TSOP (12x20mm) package will be qualify by similarity (QBS).
CN	ES348366
QUAL ID	R2000754 Rev A
MP CODE	X02035W9XA03
Part No.	SST38LF6401-90-RT/TV-ENG
Bonding No.	BDE-006342 Rev. 03
CCB#:	4279, 4279.001 and 4279.002
<u>Package</u>	
Type	48L TSOP
Package size	12 x 20 mm
<u>Lead Frame</u>	
Paddle size	330 x 260 mils
Material	C7025
Surface	Ag ring
Process	Stamped
Lead Lock	No
Part Number	11-07048-003
Treatment	None
<u>Material</u>	
Epoxy	EN-4900GC
Wire	Au
Mold Compound	G600F
Plating Composition	Matte Sn



MICROCHIP PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot No.	Wafer lot No.	Date Code
GTK-212100034.000	GC01921100652.110	2034C7Q
GTK-212200001.000	GC01921141877.220	2035C84
GTK-212200002.000	GC01921141877.220	2035C8V

Result

Pass Fail _____

48L TSOP (12x12 mm) assembled by GTK pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 3)	30°C/ 60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020E)	IPC/JEDEC J-STD-020E	135	0/135	Pass	
<u>Precondition Prior Perform Reliability Tests (At MSL Level 3)</u>	<p>Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X</p> <p>Bake 150°C, 24 hrs System: CHINEE</p> <p>30°C/60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH</p> <p>3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243</p> <p>Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X</p>	JESD22-A113	729(0)	729 729 729 729 0/729	 Pass	Good Devices

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Temp Cycle	Stress Condition: -55°C to +125°C, 500 Cycles System: TABAI ESPEC TSA-70H Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X	JESD22-A104		243		Parts had been pre-conditioned at 260°C
			243(0)	0/243	Pass	
	Bond Strength: Wire Pull (>2.5 grams)		15 (0)	0/15	Pass	
	Bond Shear (>15.00 grams)		45 (0)	0/45	Pass	
	Stress Condition: -55°C to +125°C, 1000 Cycles System: TABAI ESPEC TSA-70H Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X			243		
			243(0)	0/243	Pass	
	Bond Strength: Wire Pull (>2.5 grams)		15 (0)	0/15	Pass	
	Bond Shear (>15.00 grams)		45 (0)	0/45	Pass	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
HAST	Stress Condition: +130°C/85%RH, 96 hrs. Bias Volt: 3.6 Volts System: HAST 6000X Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X Bond Strength: Wire Pull (>2.5 grams) Bond Shear (>15.00 grams) Stress Condition: +130°C/85%RH, 192 hrs. Bias Volt: 3.6 Volts System: HAST 6000X Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X Bond Strength: Wire Pull (>2.5 grams) Bond Shear (>15.00 grams)	JESD22- A110		243		Parts had been pre-conditioned at 260°C
			243(0)	0/243	Pass	
			15 (0)	0/15	Pass	
			45 (0)	0/45	Pass	
			243			
			243(0)	0/243	Pass	
			15 (0)	0/15	Pass	
			45 (0)	0/45	Pass	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
UHAST	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		243		Parts had been pre-conditioned at 260°C	
	Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X		243(0)	0/243	Pass	77 units / lot	
	Bond Strength: Wire Pull (>2.5 grams)		15 (0)	0/15	Pass		
	Bond Shear (>15.00 grams)		45 (0)	0/45	Pass		
	Stress Condition: +130°C/85%RH, 192 hrs. System: HAST 6000X			243			
	Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X		243(0)	0/243	Pass		
	Bond Strength: Wire Pull (>2.5 grams)		15 (0)	0/15	Pass		
	Bond Shear (>15.00 grams)		45 (0)	0/45	Pass		

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
High Temperature Storage Life	Stress Condition: Bake 175°C, 500 hrs System: TPS DC-166-F-ST350	JESD22- A103		45		45 units / lot
	Electrical Test: -55°C, 25°C and 125°C System: Nextest_GV2X		45(0)	0/45	Pass	
Solderability Temp 215°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63, Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22	0/22	Pass
	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22	0/22	Pass
Physical Dimensions	Physical Dimension, 10 units / lot from 3 lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
Bond Strength Data Assembly	Wire Pull (> 2.5 grams)	Mil.Std. 883-2011	30 (0) Wires	0/30	Pass	
	Bond Shear (>15.00 grams)	CDF-AEC- Q100-001	30 (0)	0/30	Pass	

CCB 4279.002
Pre and Post Change Summary
PCN #: ASER-25RLDG830



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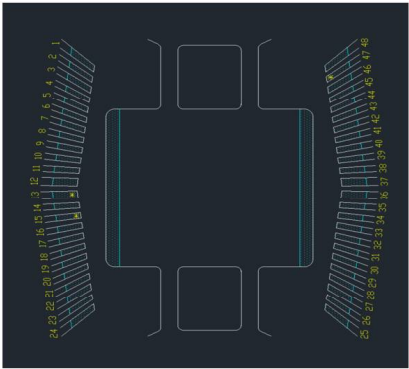
**Qualification of GTK as a new assembly site for selected
SST39VF3201xx and SST39VF3202xx device families available in 48L
TSOP (12x20mm) package.**



SMART | CONNECTED | SECURE

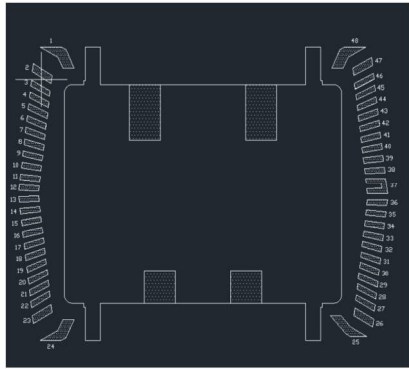
Lead frame Comparison

LPI



Paddle size	183 x 161 mils
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GTK



Paddle size	280 x 210 mils
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